

Quasi-steady-state measurement of exciton diffusion lengths in organic semiconductors

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Abstract

Exciton diffusion plays a decisive role in various organic optoelectronic applications including lasing, photodiodes, light emitting diodes, and solar cells. Understanding the role that exciton diffusion plays in organic solar cells is crucial to understanding the recent rise in power conversion efficiencies brought about by non-fullerene acceptor molecules (NFAs). Established methods for quantifying exciton diffusion lengths in organic semiconductors require specialized equipment designed for measuring high-resolution time-resolved photoluminescence (TRPL). In this article we introduce an approach, named pulsed-PLQY, to determine the diffusion length of excitons in organic semiconductors without any temporal measurements. Using a Monte-Carlo model the dynamics within a thin film semiconductor are simulated and the results are analysed using both pulsed-PLQY and TRPL methods. It is found that pulsed-PLQY has a larger operational window and depends less on the excitation fluence than the TRPL approach. The simulated results are validated experimentally on a well understood organic semiconductor, after which pulsed-PLQY is used to evaluate the diffusion length in a variety of technologically relevant materials. It is found that the diffusion lengths in NFAs are much larger than in the benchmark fullerene and that this increase is driven by an increase in diffusivity. This result helps explain the high charge generation yield in low-offset state-of-the-art NFA solar cells.

Keywords: organic semiconductors, organic solar cells, diffusion length, exciton-exciton annihilation

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I. INTRODUCTION

Organic semiconductors have shown great promise as potential materials for light emitting diodes[1], photodetectors[2], lasers[3], and solar cells[4]. Organic solar cells (OSCs), based on organic semiconductors, are a promising solar harvesting technology for many applications such as indoor and stand-alone power, due to a number of advantageous features such as low embodied energy processing, earth abundant constituent materials, suitability for flexible form factor, and tunable optoelectronic properties[4–6]. Traditional OSCs are fabricated by blending a polymer donor and a fullerene based acceptor semiconductor in solution and depositing to form a bulk heterojunction solar cell (BHJ). Due to the low dielectric constants of organic semiconductors ($\epsilon_r \sim 2-4$), absorption of photons does not directly result in free charge carriers. Rather, bound electron-hole pairs localized to either the donor or acceptor phase known as excitons are the primary photo-excited species[7]. To create free charge carriers, excitons generated in the bulk of either phase must first diffuse to the donor:acceptor interface before they decay. At the interface, an exciton generated in the donor (acceptor) phase can form a charge-transfer (CT) state by transferring the electron (hole) to the acceptor (donor) phase. This is thought to be the primary route for the generation of free charges and is therefore central to the photovoltaic process in OSCs. The transfer of an electron (hole) from the donor (acceptor) to the acceptor (donor) molecule in these cells is typically considered to be driven by an energetic offset between the lowest unoccupied (highest occupied) molecular orbital, LUMO (HOMO), levels of the two materials, known as type I (II) charge generation[4, 8–10].

The recent advent of non-fullerene acceptor (NFA) based OSCs have propelled power conversion efficiencies consistently above 15% and as high as 18.2%[11–15]. Low-offset state-of-the-art NFA BHJs, such as the benchmark PM6:Y6 system (for

a list of the chemical definitions see supplemental material [16]), have minimal offset between the HOMO levels of the donor and acceptor molecule[11, 17]. Despite this apparent disadvantage, low-offset NFA systems show dramatic increases in power conversion efficiency compared to their fullerene predecessors, brought about by increases in short-circuit current and high charge generation yield[11–13, 18, 19]. It has been conjectured that the lack of driving force is compensated for by an increase in exciton lifetime or diffusivity, amalgamated into diffusion length, increasing the attempt frequency of CT-state formation[20, 21]. Other evidence implies Förster energy transfer allows for either type I or II charge generation to occur for bulk excitons generated in either phase[22, 23]. Thorough understanding of exciton dynamics within the donor and acceptor lattices and exciton kinetics at the donor:acceptor interface is essential to explain the efficient exciton dissociation in low-offset NFA solar cells. Contributing to this understanding is the motivation behind the work presented here.

While exciton lifetimes can be discerned from time-resolved photoluminescence (TRPL) measurements, measuring the exciton diffusivity, identified by the diffusion coefficient, is not as straightforward. Exciton diffusion coefficients in organic semiconductors can be determined through a variety of optical methods including fluorescence volume[24–26] or bi-layer[24, 27–34] quenching, and exciton-exciton annihilation (EEA)[20, 26, 34–41] measurements. A robust quenching experiment requires the fabrication of multiple films with varying thickness, detailed measurement of optical constants, a precise understanding of both the heterostructure and the quenching mechanism, and in the case of steady-state measurements the absolute value of the photoluminescence quantum yield (η_{PL}). In contrast, EEA approaches require only one film with spectrally understood absorbance, do not require absolute η_{PL} measurements, and are less sensitive to both optical interference effects and long-range quenching mechanisms such as Förster energy transfer[42]. Further, EEA

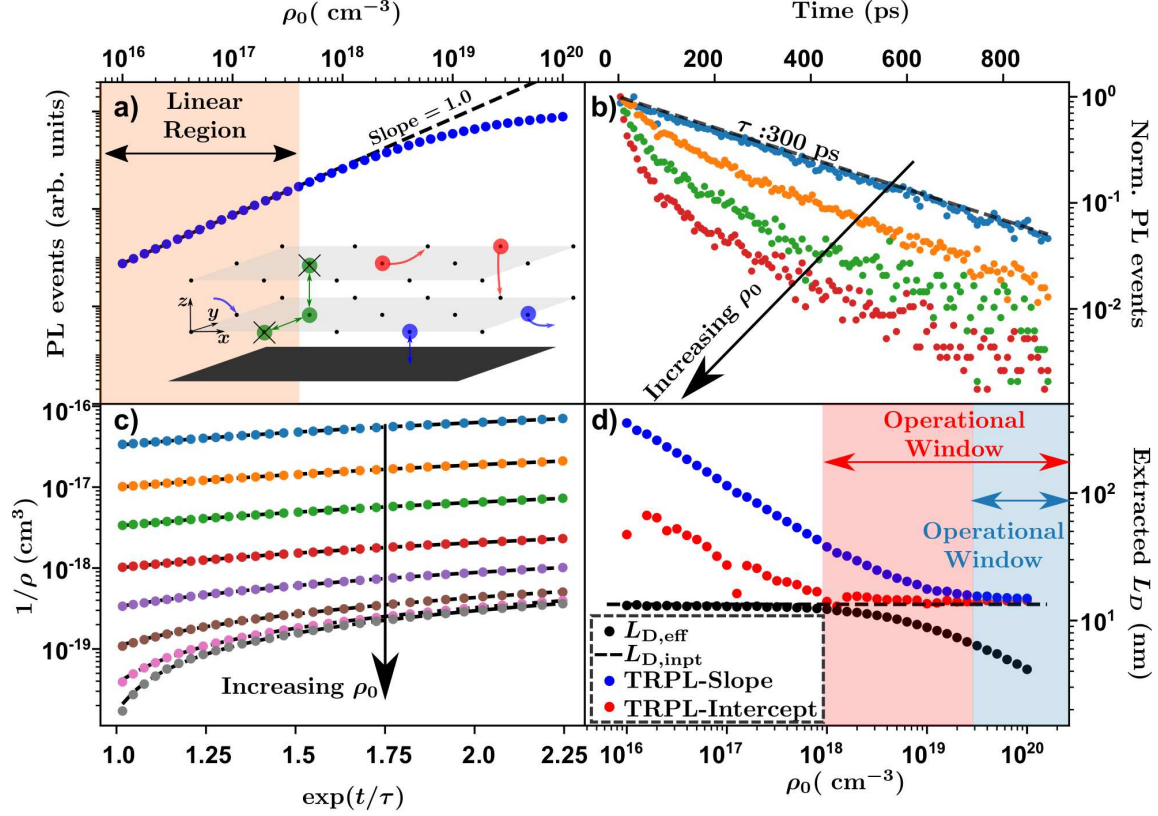


FIG. 1. Simulated (a) PL events as a function of initial excitation density, (inset) cartoon depiction of various pathways for excitons to evolve in the simulation. Red circles and arrows indicate hopping transport along major axes, blue circles and arrows indicate reflecting and periodic boundary conditions, green circles and arrows indicate exciton-exciton annihilation. Simulated (b) TRPL-decays and as a function of time and (c) linearized TRPL decays for selected initial excitation densities (circles) and corresponding fit lines (black dashed lines), note that the axis in panel (c) are log-lin. (d) Diffusion lengths extracted through TRPL-linearization (blue and red circles), calculated from Eq. A1 (black circles), or calculated from simulation parameters (black dashed line).

studies provide additional insight into exciton dynamics by observing exciton-exciton interactions at high excitation densities. This ancillary information allows for the determination of the annihilation coefficient, important to the field of organic lasing, and the so called exciton capture radius, defined as the average distance at which excitons annihilate.

In the majority of experimental reports employing EEA the annihilation coefficient is measured through linearizing TRPL data at high excitation densities, while the capture radius is assumed to be on the order of the molecular spacing, allowing for the calculation of the low-density diffusion length[34, 35, 37, 38]. In some studies authors further compare diffusion length and annihilation coefficient from two independent methods to gain insight into the capture radius, however; this requires the assumption of a perfect quenching molecule or interface[20, 34, 39]. Still others use global fitting techniques, including the capture radius as either a fitting parameter or an assumed value[20, 26, 41]. Recent studies found the d_{100} lamellar spacing measured by grazing-incident wide-angle X-ray scattering experiments (GIWAX) to be a close estimation of the capture radius[20]. Although a reliable method for determining the capture radius is yet to be agreed upon, EEA has been a useful tool in determining the exciton diffusion length of many organic semiconductors[42].

In this work, we explore the limitations of EEA experiments by evaluating the density dependence of the diffusion length extracted from TRPL-linearization using a Monte-Carlo hopping model. Then an alternative EEA approach which does not require any temporal measurements, termed pulsed-PLQY, is proposed and demonstrated via the same Monte-Carlo simulations. The use of Monte-Carlo simulations allows for the identification of operational windows, defined as the range of densities over which each analysis of the simulated kinetics reproduces the input diffusion length. It is found that, even in the ideal case, pulsed-PLQY has a larger operational window and is less sensitive to the choice of initial exciton density compared to the

traditional TRPL-linearization technique. TRPL-linearization and pulsed-PLQY are performed on the well studied model system P3HT and compared. Both experiments reproduce the trends predicted by the simulations. Overall it is found that pulsed-PLQY is less dependent on the excitation fluence, is faster, easier, and requires less specialized equipment than the traditional EEA measurement techniques. Finally, pulsed-PLQY is used to measure the annihilation coefficient, diffusion length, and diffusion coefficient in various organic semiconductors. It is found that diffusion lengths in NFA organic semiconductors are longer than those found in fullerene acceptors and that this difference is driven by an increase in diffusivity.

II. THEORETICAL BACKGROUND

Singlet-singlet exciton annihilation can occur when two excitons interact with each other, typically assumed to be on neighbouring molecules. The result of this interaction is an exciton with excess energy, which quickly relaxes to the lowest excited-state, and one non-radiative decay event to the ground state. The rate equation for the density of excitons (ρ) in an organic semiconductor is determined by the sum of this second order non-radiative decay and the first order natural decay

$$\frac{d\rho(t)}{dt} = -\frac{\rho(t)}{\tau} - \gamma\rho^2(t) \quad (1)$$

where t is the time, τ is the natural (low-density) lifetime for singlet excitons, and γ is the exciton-exciton annihilation coefficient. When the process of annihilation is diffusion-limited γ can be related to the diffusion constant (D) in the film as[43]

$$\gamma = 4\pi DR_0 \quad (2)$$

where R_0 is the capture radius. Although, interactions that result in quenching of both excitons and lead to a value for γ twice what is derived here have been

proposed[36], previous experimental reports by other authors have confirmed that the primary quenching mechanism in organic semiconductors is accurately described by Eqs. 1 and 2 [20, 34, 35, 37–40, 42].

The solution to Eq. 1 is

$$\rho(t) = \frac{\rho_0 \exp(-t/\tau)}{1 + \gamma\rho_0\tau [1 - \exp(-t/\tau)]} \quad (3)$$

where ρ_0 is the initial exciton density (at $t = 0$). Eq. 3 can be linearized as

$$\frac{1}{\rho(t)} = \left[\frac{1}{\rho_0} + \gamma\tau \right] \exp(t/\tau) - \gamma\tau \quad (4)$$

allowing for γ to be obtained from either slope or intercept of a $1/\rho$ vs $\exp(t/\tau)$ plot, assuming τ is known. Finally, the annihilation coefficient can be related to the low-density diffusion length (L_D), through Eq. 2, noting that

$$L_D = \sqrt{2nD\tau} \quad (5)$$

where n is the dimensionality of the diffusion, although some researchers choose to drop the factor of 2 for convenience.

III. RESULTS AND DISCUSSION

To investigate the limits of TRPL-linearization and to introduce pulsed-PLQY the two methods were simulated using a Monte-Carlo hopping model. The simulations were limited to capture only the relevant physics and to allow for each experimental method to be evaluated under ideal conditions where system parameters, such as the diffusion length, are known and can be compared to the extracted values. To this end, the exciton dynamics within a lattice were simulated over a range of initial excitation densities with a 3D Monte-Carlo model limited to nearest neighbour hopping pairs but including both natural (linear) and exciton-exciton annihilation decay

mechanisms (as shown in the inset of Figure 1 (a)). Here, exciton-exciton annihilation is assumed to occur when excitons are within one lattice spacing of one another (corresponding to an R_0 equal to the lattice spacing). Although it is possible that exciton-exciton annihilation occurs both over greater distances and as a statistical process, the capture radius is typically understood to be the average distance over which annihilation occurs. Limiting the annihilation to one lattice spacing allows for an absolute calculation of the diffusion length through Eqs. 2 and 5 (with R_0 equal to the lattice spacing) and a direct comparison of the diffusion length calculated from the simulated TRPL-linearization and pulsed-PLQY techniques. Further, the finding that the GIWAX d_{100} spacing is similar to the capture radius experimentally corroborates the view that annihilation, on average, happens between nearest neighbour pairs[20]. The lattice spacing (dx), temporal step size, and natural lifetime used were 0.775 nm, 1 ps, and 300 ps respectively, corresponding to a diffusion coefficient of 10^{-3} cm²/s and an input 3D diffusion length ($L_{D,\text{inpt}}$) of 13.4 nm. The details of the Monte-Carlo Model are outlined in Appendix A.

Figure 1 (a) shows the photoluminescence, determined by the number of natural decay events, as a function of initial exciton density. A transition between first and second-order response, as expected from Eq. 1, can clearly be seen starting around 3×10^{17} cm⁻³ and fully occurring by 3×10^{18} cm⁻³. This is reflected in the increased quenching occurring on sub-100 ps time scale in the selected TRPL curves shown in Figure 1 (b), typical of exciton-exciton annihilation experiments[20, 26, 34–41].

To explore the limits of Eq. 4 the simulated TRPL data was analyzed, through TRPL-linearization, to obtain the diffusion length and compare with $L_{D,\text{inpt}}$. In this technique the lowest density TRPL data is fit to obtain τ as shown by the black dashed line in Figure 1 (b). Using this value of τ each TRPL decay is linearized according to Eq. 4 and fit to a line, as shown for the selected curves in Figure 1 (c). The slope and intercept are used to obtain values of γ for each initial density and the

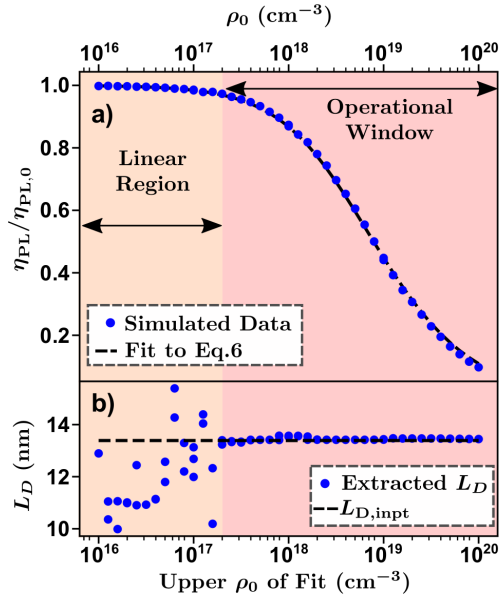


FIG. 2. (a) Simulated η_{PL} as a function of initial excitation density (blue circles) and fit to Eq. 6 (black dashed line). (b) Exciton diffusion length extracted from data in panel (a) as a function of the upper limit to the fit (blue circles) and input diffusion length (black dashed line).

diffusion length is calculated from Eqs. 2 and 5, using $R_0 = dx$. This is equivalent to the procedure for fitting experimental data.

The black dashed line in Figure 1 (d) shows the input diffusion length ($L_{D,\text{inpt}}$) and the black circles indicate the effective diffusion length ($L_{D,\text{eff}}$, calculated from simulated exciton dynamics, see appendix A) of the simulated excitons as a function of initial density. At low-densities $L_{D,\text{eff}}$ predicts $L_{D,\text{inpt}}$, however, $L_{D,\text{eff}}$ increasingly underestimates $L_{D,\text{inpt}}$ with increasing ρ_0 . This is due to an increase in exciton-exciton annihilation occurring at large ρ_0 , where, on average, excitons have a shorter effective lifetime (and therefore move, on average, less distance) than those at low-densities. It is therefore expected that $L_{D,\text{eff}}$ will decrease with increasing ρ_0 .

In contrast to this, the blue and red circles in Figure 1 (d), respectively, show the diffusion lengths extracted from the slope and intercept of the fit to the linearized simulated TRPL data. The extracted diffusion lengths reproduce $L_{D,\text{inpt}}$ at high ρ_0 , where the second-order non-radiative decay dominates Eq. 1. However, the diffusion length (or γ) extracted from the slope increasingly overestimates the input diffusion length with decreasing ρ_0 . Similar reduction in extracted annihilation coefficient (as measured by high density TRPL experiments) with increasing excitation density has been observed by other researchers in previous studies on organic semiconducting polymers[35].

The apparent dependence of the slope on ρ_0 limits the range over which the true value of γ (and hence L_D) can be extracted and the extracted value converges to the expected low-density diffusion length only when $\gamma\tau \gg 1/\rho_0$. The operational window is defined as the range of densities over which this technique reliably reproduces the low-density diffusion length. The operational window for extraction from the slope is indicated by the blue shading in Figure 1 (d). On the other hand, according to Eq. 4, the intercept does not depend on ρ_0 . This is reflected in the larger operational window for the diffusion length extracted from the intercept (red shaded region in Figure 1 (d)). However, in the limit where $\rho_0\gamma\tau \ll 1$ Eq. 3 is reduced to a single exponential decay and one cannot expect to extract any second-order information, reflected in the increasing overestimation of the diffusion length as the density approaches the linear regime.

Consequently, accurate quantification of the diffusion length (or γ) from TRPL-linearization requires careful analysis of the range of excitation densities used. Implementation of this experimental procedure requires a femtosecond pulsed laser source to inject (and subsequently let evolve) the initial exciton density, accurate measurement of the natural lifetime, and specialized equipment capable of measuring the quenching kinetics seen in Figure 1 (b), which occur on the order of picoseconds in

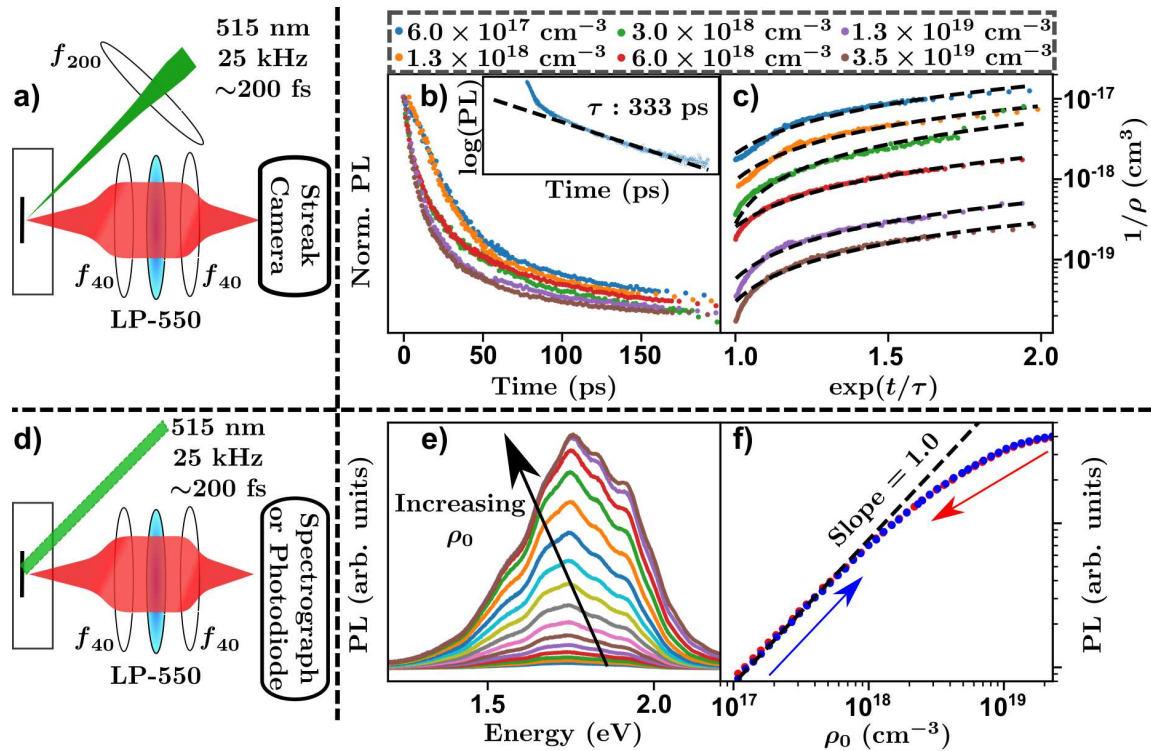


FIG. 3. (a) TRPL measurement apparatus. (b) Normalized TRPL decays as a function of time and (c) linearized TRPL decays for various initial excitation densities. (d) Pulsed-PLQY measurement apparatus. (e) P3HT spectra for selected excitation densities. (f) P3HT peak PL counts as a function of initial excitation density. $f_{200/40}$ indicate focal lengths of lenses, LP-long pass filter.

organic semiconductors[20, 26, 34, 36–38, 40]. Furthermore, as described above, the operational window for determining the diffusion length (or γ) of these materials occurs at high excitation density where the quenching is fastest requiring increasing resolution to resolve. Besides which, not all organic semiconductors are stable at high excitation densities and may undergo photo- or thermal-oxidation at sufficiently high excitation fluences.

To circumvent the apparent dependence of extracted values on the choice of initial density, eliminate the requirements for measuring the natural lifetime, lower the equipment specialization, and increase the speed of the measurement one can measure and analyze these kinetics in an alternative way by considering the normalized photoluminescence quantum efficiency (η_{PL}) as a function of initial density. The total number of excitons that recombine via natural decay in accordance with Eq. 1 is $\rho_{\tau} = \int_0^{\infty} \rho(t)/\tau dt$. On the other hand, the photoluminescence quantum efficiency is given by $\eta_{\text{PL}} = \rho_{\tau}\eta_{\text{PL},0}/\rho_0$ where $\eta_{\text{PL},0}$ is the low density photoluminescence quantum efficiency. From Eq. 3, the photoluminescence quantum efficiency is then obtained as

$$\eta_{\text{PL}}(\rho_0) = \eta_{\text{PL},0} \frac{\ln[1 + \rho_0\gamma\tau]}{\rho_0\gamma\tau} \quad (6)$$

Therefore, by measuring $\eta_{\text{PL}}/\eta_{\text{PL},0}$ as a function of ρ_0 one can fit to obtain the product of $\gamma\tau$ and either: (i) calculate the the diffusion length directly using Eqs. 2 and 5 without the need for any temporal measurements, or (ii) measure the natural lifetime to calculate γ (or D).

To evaluate the validity of this procedure, η_{PL} was calculated from the results of the Monte-Carlo simulations as the ratio of natural decay events to the initial number of excitons in the lattice. Figure 2 (a) shows the results of this analysis, the blue circles indicate η_{PL} calculated for each initial density. The exciton-exciton annihilation is evident in the decrease in η_{PL} with increasing ρ_0 , as observed experimentally by other researchers in studies on metal-insulator-semiconductor heterostructures[44, 45]. The linear region marked in Figure 1 (a) is reproduced in Figure 2 as a guide.

The simulated normalized η_{PL} is fit to Eq. 6, as shown by the black dashed line and the diffusion length is calculated from the extracted product of $\gamma\tau$ through Eqs. 2 and 5. Figure 2 (b) shows the calculated diffusion length as a function of

the upper limit to the fitting. The operational window is defined as the densities that, when used as the upper limit to the fitting, reproduce the low-density diffusion length. The operational window for pulsed-PLQY is shown by the red shaded region in Figure 2 (a) and (b). The operational window for pulsed-PLQY is larger and begins at lower densities than those of TRPL-linearization and, most importantly, the confidence in the extracted value increases with increasing number of initial densities used. Whereas, in TRPL-linearization increases in the number of measurements made at varying initial densities may decrease the confidence of the extracted values, depending on the choices of ρ_0 .

Actual realization of this experiment requires the same femtosecond pulsed laser as with TRPL-linearization, however, the light-collection can be accomplished with non-specialized equipment operating at a quasi-steady state. Further, the exciton diffusion length can be calculated directly from the product $\gamma\tau$ without the need for any temporal measurements, and γ (or D) can be determined without the need for a high resolution TRPL apparatus.

To validate these simulations TRPL-linearization and pulsed-PLQY were carried out on a P3HT thin film and the results compared. Figure 3 (a) shows the experimental TRPL-linearization apparatus (detailed in Appendix B). Figure 3 (b) shows the resulting normalized TRPL decays, where the expected time-independent quenching dynamics can be seen, akin to other studies on similar materials[20, 26, 34, 35, 37–39, 41]. The natural lifetime was measured by fitting the decay of the lowest initial density to the linear region (where exciton-exciton annihilation is minimal) on a log-lin scale as shown in the inset of Figure 3 (b). The natural lifetime was used to linearize all the TRPL decays in Figure 3 (b) according to Eq. 4, as shown in Figure 3 (c). The black dashed lines indicate the fits used to extract the annihilation coefficient from the intercept, as this was shown to be the more accurate measure.

Figure 3 (d) shows the apparatus used for the pulsed-PLQY technique (detailed in

Appendix B). Selected spectra obtained from the same P3HT thin film are shown in Figure 3 (e). The peak values of the spectra are plotted against the excitation density in Figure 3 (f). The transition from the linear to sub-linear response can be clearly seen occurring around the same values as those in Figure 1 (a). To ensure that there was no degradation of the sample during these measurements both forward (blue circles-from low to high density) and reverse (red circles-from high to low-density) scans were performed consecutively. To calculate the relative η_{PL} the peak value of the photoluminescence data was divided by the associated ρ_0 and normalized to the η_{PL} of the lowest density points, as shown by the blue circles in Figure 4 (a). To exemplify the simplicity of this measurement a second set of data was collected where the imaging spectrograph was replaced with a silicon photodiode and the voltage response was used to calculate the relative η_{PL} . This second data set is shown as the orange squares in Figure 4 (a). Although the use of a silicon photodiode does not provide spectral information, the relative η_{PL} , and therefore $\gamma\tau$ (or L_D), can be measured with a further reduction in equipment specialization. The η_{PL} data collected with the spectrograph are fit to Eq. 6, shown by the black dashed line, and the extracted product of $\gamma\tau$ is used, with the d_{100} spacing as an estimate of R_0 , to calculate the diffusion length via Eqs. 2 and 5.

The results of the experiments on P3HT are summarized in Figure 4 (b) which shows the 1D diffusion length extracted from TRPL-linearization as a function of initial density and pulsed-PLQY as a function of upper limit to the fit. As predicted by the simulations the diffusion length extracted from TRPL-linearization (red circles) decreases with increasing initial density. The diffusion length measured by pulsed-PLQY (blue circles) converges to a constant value with increasing upper fitting limit. These results verify the simulations and demonstrate that pulsed-PLQY is a viable and accurate alternative measurement technique for measuring diffusion lengths without the need for any temporal measurements, or the annihilation coeffi-

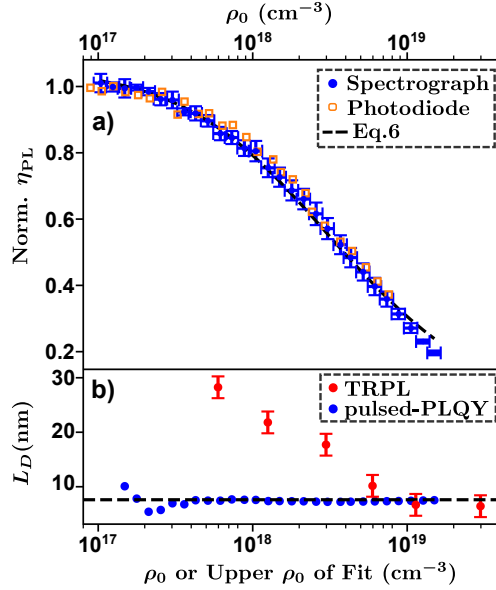


FIG. 4. P3HT (a) pulsed-PLQY data collected using spectrograph (blue circles) and lock-in (orange squared) detection, and fitting of spectrograph data to Eq. 6 (black line). (b) Diffusion lengths extracted from the intercept of TRPL-linearization as a function of initial density (red circles) and pulsed-PLQY as a function of upper limit to the fit.

cient without the need for high resolution TRPL equipment.

The product of $\gamma\tau$ found from pulsed-PLQY was $(7.2 \pm 0.2) \times 10^{-19} \text{ cm}^3$ (for a detailed description of error analysis see supplemental material[16]), leading to a 1D diffusion length of $8 \pm 1 \text{ nm}$, comparable to literature values[34, 42]. Using the natural lifetime, found to be $330 \pm 10 \text{ ps}$, a value of $\gamma = (2.15 \pm 0.08) \times 10^{-9} \text{ cm}^{-3}$ was found for the annihilation coefficient, slightly lower than previous values extracted from TRPL-linearization[34]. However, as exemplified by the simulations, a slightly lower value of γ is expected from pulsed-PLQY than from TRPL-linearization. Finally, the diffusion coefficient was calculated from γ , and R_0 according to Eq. 2 and found to be $(1.0 \pm 0.3) \times 10^{-3} \text{ cm}^2/\text{s}$, in agreement with previous values from quenching

TABLE I. Material parameters extracted from the pulsed-PLQY fittings ($\gamma\tau$ and L_D), low-density TRPL fittings (τ), and subsequently calculated (γ , and D) for various organic semiconductors. See supplemental material for all measurement data[16]. R_0 is assumed to be the d_{100} spacing taken from the provided references, the error in R_0 is assumed half the value given by the d_{100} spacing. †PC₆₀BM estimate for R_0 is taken as 1 nm as GIWAX d_{100} does not give intermolecular distance in this case.

Material	$\gamma\tau(\times 10^{-18})$ (cm ³)	R_0 (nm)	L_D^{1D} (nm)	L_D^{3D} (nm)	τ (ps)	$\gamma(\times 10^{-9})$ (cm ³ /s)	$D(\times 10^{-4})$ (cm ² /s)
PM6	0.088±0.002	2.1[11]	2.6±0.3	4.5±0.3	64	1.4±0.2	5±1
P3HT-Regiorandom	0.134±0.02	1.0[46]	5±1	8±1	175	0.76±0.05	6±3
PTB7-Th	0.144±0.004	2.4[46]	3.1±0.3	5.4±0.3	123	1.17±0.09	3.9±0.9
PCDTBT	0.329±0.005	1.6[47]	5.7±0.9	9.9±0.9	203	1.62±0.08	8±2
PC ₆₀ BM	0.52±0.01	1.0 [†]	9±2	23±3	777	0.65±0.02	5±2
P3HT-Regioregular	0.72±0.02	1.0[48]	8±1	14±1	333	2.15±0.08	10±3
ITIC (NFA)	1.23±0.03	1.6[49]	11±2	19±2	120	10.3±0.9	50±10
IT4F (NFA)	2.54±0.07	1.8[50]	15±2	26±2	205	12.4±0.7	60±10
Y6 (NFA)	8.5±0.2	1.5[11]	30±5	51±5	799	10.6±0.3	60±10
BTP-eC9 (NFA)	10.6±0.3	1.6[12]	33±5	56±5	389	27±1	140±40

experiments[26, 34].

After pulsed-PLQY was established it was used to evaluate $\gamma\tau$ and the subsequent 1D and 3D diffusion lengths in a collection of organic semiconductors, including several technologically relevant NFAs used in state-of-the-art organic solar cells. Further, the natural lifetime was measured, at low excitation density, to evaluate the annihilation and diffusion coefficients. These results are summarized in Table I. The NFAs (such as ITIC, IT4F, Y6, and BTP-eC9) were found to have much longer

diffusion lengths than the benchmark fullerene acceptor PC₆₀BM. Measurement of the natural lifetime shows that the increase in diffusion length is driven by increased diffusivity. Increases in diffusivity would allow bulk excitons to form interfacial excitons many times over, increasing the probability of CT-state formation regardless of HOMO offset. However, this evidence does not rule out Förster energy transfer playing a significant role in charge generation. The Förster radii, defined as the range at which natural decay and long range transfer rates are equivalent, is < 5 nm in BHJs made from these materials[22]. If Förster energy transfer were to occur, suppressing one charge generation channel, increased diffusion lengths would still increase charge generation by increasing the number of bulk excitons that diffuse close enough to the interface for long-range Förster energy transfer to efficiently transfer the exciton to the other phase. Alternatively, for excitons that have undergone Förster energy transfer to the bulk of the other phase increased diffusivity would increase the chance of forming a interfacial exciton from the new phase.

IV. CONCLUSIONS

In conclusion, pulsed-PLQY was introduced as an alternative approach to established exciton-exciton annihilation techniques. A Monte-Carlo hopping model was used to validate the experimental technique and the subsequent results on P3HT agree with the models predictions. Pulsed-PLQY was then used to determine the diffusion lengths of various organic semiconductors and the results show a dramatic increase in diffusion length in NFA materials, primarily driven by increased diffusivity. These results support the assertion that increases in diffusion constant contribute to the charge generation efficiency in low-offset NFA based organic solar cells. Pulsed-PLQY will contribute to the field of organic photovoltaics specifically, and organic optoelectronics more broadly, by providing an alternative technique to

measure the diffusion length in organic semiconductors without the need for temporal measurements, or to measure annihilation coefficients without the need for a high resolution TRPL apparatus.

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Appendix A: Monte-Carlo Model

With the aim of modelling the dynamics within an organic semiconductor a 3D Monte-Carlo hopping model was invoked[51]. First a lattice of sufficient volume (V) to accommodate the input density was created with spacing between each point dx . The lattice is randomly populated with N excitons (where $N = \rho_0 V$). Once the lattice has been initialized the simulation is evolved in time with a temporal step-size dt , defining the diffusion coefficient as $D = dx^2/6dt$.

The inset in Figure 1 (a) (main text) indicates the various pathways an exciton in

the system can evolve. The green circles and arrows indicate annihilation, where any exciton within one lattice spacing of another will decay non-radiatively via exciton-exciton annihilation, such that R_0 in Eq. 2 equals dx . The red circles and arrows in the inset of Figure 1 (a) indicate an exciton hopping to an adjacent lattice site along the major axes. The choice of site to hop to is given by the Gillespie algorithm with equal probability for movement in each direction but limited to nearest neighbour pairs, and a maximum hopping rate given by the inverse of the temporal step size[52]. The amount of time the exciton occupies this new site (the dwell-time, τ_{Dwell}) is given by the total hopping rate away from the site (Γ_i) as $\tau_{\text{Dwell}} = T/\Gamma_i$, where T is a pseudo-random number generated from an exponential distribution with unit expectation value and unit variance.

To simulate a thin film deposited on glass periodic boundary conditions on the x and y axis and reflecting boundary conditions on the z axis were implemented, as indicated by the blue circles and arrows in the inset of Figure 1 (a). Further, the size of the z dimension was held at 50 nm. The final pathway for an exciton to evolve is natural decay. The probability of natural decay is given by the input natural lifetime (τ) as dt/τ . Therefore, after each dwell time a pseudo-random number on a unit interval is generated, an exciton decays naturally when this is smaller than the decay probability.

Once the system has sufficiently evolved the effective diffusion length can be found from the Euclidean distance travelled by each exciton (L_i)

$$L_{D,\text{eff}} = \sqrt{\frac{\sum_0^N (L_i)^2}{N}} \quad (\text{A1})$$

which will converge to the input diffusion length ($L_{D,\text{input}} = \sqrt{6D\tau}$) in the low-density limit.

Appendix B: Experimental

Time Resolved Photoluminescence: The thin films were held in a cryostat (Linkam LTS420) under a constant flow of nitrogen gas to prevent photo-oxidation[53], and an initial density of excitons ($\rho_0 = P_{\text{abs}}/\pi\omega^2 f_{\text{rep}} E_{\text{ph}} d$, P_{abs} -absorbed laser power, f_{rep} -repeate and ω -spotsizes of the laser, see supplemental material[16, 54], E_{Ph} -incident photon energy, d -film thickness) is injected by an ultrafast laser source (Pharos PHM02-2H-3H). The resulting photoluminescence is collimated, filtered to remove scattered pump light, and focused into the streak camera (Hamamatsu C14831).

Pulsed-PLQY: Here the focusing lens is removed from the laser path in order to make a uniform (in-plane) distribution of excitons and the streak camera is replaced with an imaging spectrograph (Hamamatsu C14631-03), or a photo-diode (Thorlabs SM1PD1A) connected to a lock-in amplifier (Stanford Research Systems SR860), with the pump laser chopped at the reference frequency. A complete schematic and description of the pulsed-PLQY apparatus using a photo-diode is included in the supplementary material [16].

Film thickness: The film thickness was measured from ellipsometry data (J.A. Woolam M-2000 Spectroscopic Ellipsometer).

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